

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/665,115	UTSUMI ET AL.	
Examiner		Art Unit		Page 1 of 1
David W. Scheuermann		2834		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 09065617 A	03-1997	Japan	KITAZAWA, KANJI	H02K 11/00
	O	JP 2004159449 A	06-2004	Japan	UCHIUMI et al.	H02K 11/00
	P	JP 2004157056 A	06-2004	Japan	OKAZAKI et al.	G01D 05/245
	Q	EP 863383 A1	09-1998	European Patent	DULIN et al.	G01D 05/20
	R	JP 2001231218 A	08-2001	Japan	HIRANO et al.	H02K 11/00
	S	JP 2001191931 A	07-2001	Japan	SESHIMO et al.	B62D 05/04
	T	JP 03296617 A	12-1991	Japan	MIMURA, HISAFUMI	G01D 05/245

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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